

Issue Classification		Application/Control No.	Applicant(s)/Patent under Reexamination	
		10/776,286	ONOZAWA ET AL.	
		Examiner	Art Unit	
		Leith A. Al-Nazer	2821	

ORIGINAL		CROSS REFERENCE(S)					
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
345	55	345	60	204			
INTERNATIONAL CLASSIFICATION		315	169.1	169.2	169.3	169.4	
G 09	G 3/20						
G 09	G 3/28						
G 09	G 3/10						
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	/						
Leith A. Al-Nazer 2/27/06 (Assistant Examiner) (Date)		Don Wong 3/3/06 DON WONG SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date)					Total Claims Allowed: 3
Q.Brown 3/8/06 (Legal Instruments Examiner) (Date)		O.G. Print Claim(s) 1			O.G. Print Fig. 7		

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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